


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/701,202	LEE, BENJAMIN MICHAEL	
	Examiner	Art Unit	
	Kien T. Nguyen	3711	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
472		118		5	120				
INTERNATIONAL CLASSIFICATION				297	273				
A	6	3	G						
				09/12					
				/					
				/					
				/					
				/					
							Total Claims Allowed: 2		
(Assistant Examiner) (Date)				Kien Nguyen			O.G. Print Claim(s)		O.G. Print Fig.
(Legal Instruments Examiner) (Date)				(Primary Examiner) (Date)			1		1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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